BC549C, BC550C

Low Noise Transistors

NPN Silicon

Features

• These are Pb–Free Devices*

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector – Emitter Voltage BC549C BC550C	V _{CEO}	30 45	Vdc
Collector – Base Voltage BC549C BC550C	V _{CBO}	30 50	Vdc
Emitter-Base Voltage	V_{EBO}	5.0	Vdc
Collector Current – Continuous	Ι _C	100	Vdc
Total Device Dissipation @ $T_A = 25^{\circ}C$ Derate above = $25^{\circ}C$	PD	625 5.0	mW mW/°C
Total Device Dissipation @ $T_A = 25^{\circ}C$ Derate above = $25^{\circ}C$	P _D	1.5 12	W mW/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-55 to +150	°C

THERMAL CHARACTERISTICS

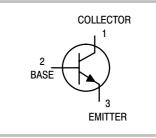
Characteristic	Symbol	Мах	Unit	
Thermal Resistance, Junction-to-Ambient	R_{\thetaJA}	200	°C/W	
Thermal Resistance, Junction-to-Case	R_{\thetaJC}	83.3	°C/W	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



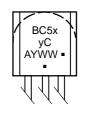
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MARKING DIAGRAM



(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping
BC549CG	TO-92 (Pb-Free)	5000 Units / Bulk
BC550CG	TO–92 (Pb–Free)	5000 Units / Bulk

*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS		•	•	•	
Collector – Emitter Breakdown Voltage $(I_C = 10 \text{ mAdc}, I_B = 0)$	V _{(BR)CEO}	45	_	_	Vdc
Collector – Base Breakdown Voltage ($I_C = 10 \ \mu Adc, I_E = 0$)	V _{(BR)CBO}	50	-	_	Vdc
Emitter – Base Breakdown Voltage ($I_E = 10 \ \mu Adc, I_C = 0$)	V _{(BR)EBO}	5.0	_	_	Vdc
Collector Cutoff Current ($V_{CB} = 30 \text{ V}, I_E = 0$) ($V_{CB} = 30 \text{ V}, I_E = 0, T_A = +125^{\circ}C$)	I _{CBO}			15 5.0	nAdc μAdc
Emitter Cutoff Current ($V_{EB} = 4.0 \text{ Vdc}, I_C = 0$)	I _{EBO}	_	-	15	nAdc
ON CHARACTERISTICS	·				
DC Current Gain (I _C = 10 μ Adc, V _{CE} = 5.0 Vdc) (I _C = 2.0 mAdc, V _{CE} = 5.0 Vdc)	h _{FE}	100 420	270 500	_ 800	-
	V _{CE(sat)}	_ _ _	0.075 0.3 0.25	0.25 0.6 0.6	Vdc
Base–Emitter Saturation Voltage ($I_C = 100 \text{ mAdc}, I_B = 5.0 \text{ mAdc}$)	V _{BE(sat)}	-	1.1	_	Vdc
$\begin{array}{l} \text{Base-Emitter On Voltage} \\ (I_{C} = 10 \; \mu \text{Adc}, \; V_{CE} = 5.0 \; \text{Vdc}) \\ (I_{C} = 100 \; \mu \text{Adc}, \; V_{CE} = 5.0 \; \text{Vdc}) \\ (I_{C} = 2.0 \; \text{mAdc}, \; V_{CE} = 5.0 \; \text{Vdc}) \end{array}$	V _{BE(on)}	_ _ 0.55	0.52 0.55 0.62	- - 0.7	Vdc
SMALL-SIGNAL CHARACTERISTICS					
Current-Gain — Bandwidth Product ($I_C = 10 \text{ mAdc}, V_{CE} = 5.0 \text{ Vdc}, f = 100 \text{ MHz}$)	f _T	_	250	_	MHz
Collector–Base Capacitance $(V_{CB} = 10 \text{ Vdc}, I_E = 0, f = 1.0 \text{ MHz})$	C _{cbo}	-	2.5	-	pF
Small–Signal Current Gain ($I_C = 2.0 \text{ mAdc}, V_{CE} = 5.0 \text{ V}, f = 1.0 \text{ kHz}$)	h _{fe}	450	600	900	-

Noise Figure

1. I_B is value for which I_C = 11 mA at V_{CE} = 1.0 V. 2. Pulse test = 300 μ s – Duty cycle = 2%.

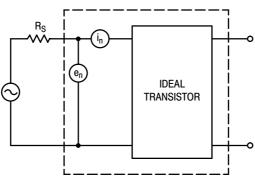


Figure 1. Transistor Noise Model

 $\frac{NF_1}{NF_2}$

dB

2.5

10

0.6

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_

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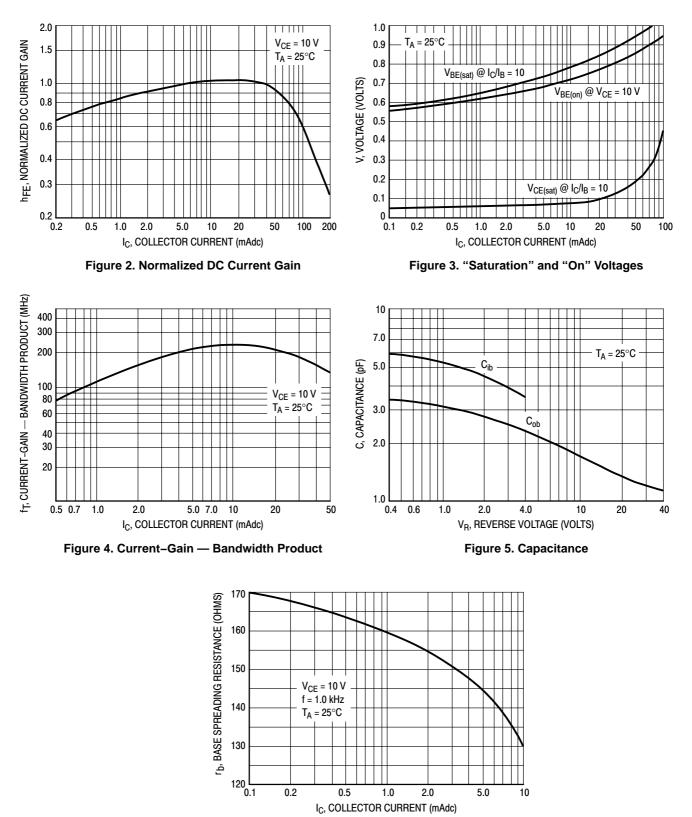
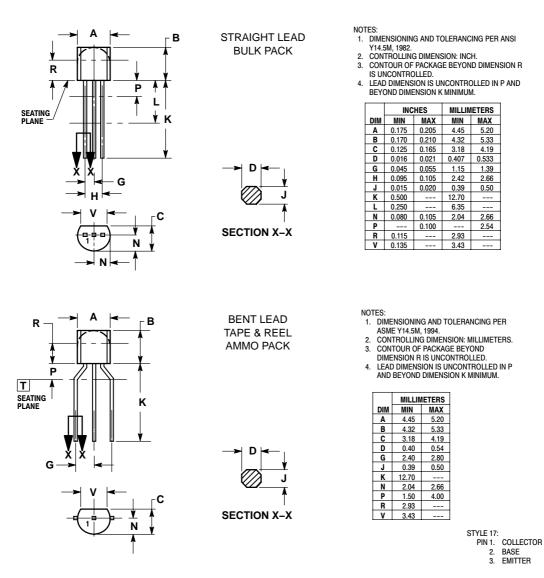


Figure 6. Base Spreading Resistance

PACKAGE DIMENSIONS

TO-92 (TO-226) CASE 29-11 ISSUE AM



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